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SN74LVC245A

SCAS218X – JANUARY 1993 – REVISED JANUARY 2015

SN74LVC245A Octal Bus Transceiver With 3-State Outputs

1 Features

- Operates From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 6.3 ns at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25° C
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC} = 3.3 V, T_A = 25° C
- I_{off} Supports Live Insertion, Partial-Power-Down Mode and Back Drive protection
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V_{CC})
- Latch-Up Performance Exceeds 250 mA
 Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model
 - 1000-V Charged-Device Model

2 Applications

Tools &

Software

- Cable Modem Termination Systems
- Servers
- LED Displays
- Network Switches
- Telecom Infrastructure
- Motor Drivers
- I/O Expanders

3 Description

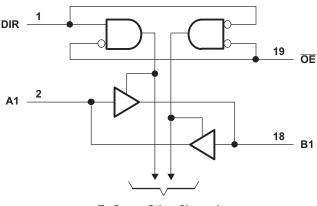
These octal bus transceivers are designed for 1.65-V to 3.6-V V_{CC} operation. The 'LVC245A devices are designed for asynchronous communication between data buses.

(1)

Device Information ⁽¹⁾								
PART NUMBER	PACKAGE (PIN)	BODY SIZE						
	VQFN (20)	4.50 mm × 3.50 mm						
	SSOP (20)	7.50 mm × 5.30 mm						
SN74LVC245A	TSSOP (20)	6.50 mm × 4.40 mm						
	TVSOP (20)	5.00 mm × 4.40 mm						
	SOIC (20)	12.80 mm × 7.50 mm						

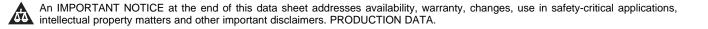
(1) For all available packages, see the orderable addendum at the end of the data sheet.

4 Simplified Schematic



To Seven Other Channels

Pin numbers shown are for the DB, DGV, DW, N, NS, PW, and RGY packages.



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5 Revision History

Changes from Revision W (May 2013) to Revision X

Typical Characteristics, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section. 1

•	Deleted Ordering Information table.		1
CI	hanges from Revision V (September 2010) to Revision W	Pag	е

٠	dded -40°C to 125°C temperature specification to Recommended Operating Conditions table	
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Added Applications, Device Information table, Pin Functions table, ESD Ratings table, Thermal Information table,

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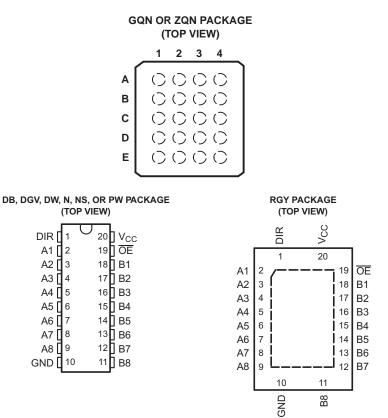
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Mechanical, Packaging, and Orderable



6 Pin Configuration and Functions



Pin Functions	
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PIN				
NAME	DB, DGV, DW, NS, PW, and RGY	GQN or ZQN	TYPE	DESCRIPTION
A1	2	A1	I/O	Transceiver I/O pin
A2	3	B3	I/O	Transceiver I/O pin
A3	4	B1	I/O	Transceiver I/O pin
A4	5	C2	I/O	Transceiver I/O pin
A5	6	C1	I/O	Transceiver I/O pin
A6	7	D3	I/O	Transceiver I/O pin
A7	8	D1	I/O	Transceiver I/O pin
A8	9	E2	I/O	Transceiver I/O pin
B1	18	B4	I/O	Transceiver I/O pin
B2	17	B2	I/O	Transceiver I/O pin
B3	16	C4	I/O	Transceiver I/O pin
B4	15	C3	I/O	Transceiver I/O pin
B5	14	D4	I/O	Transceiver I/O pin
B6	13	D2	I/O	Transceiver I/O pin
B7	12	E4	I/O	Transceiver I/O pin
B8	11	E3	I/O	Transceiver I/O pin
DIR	1	A2	I	Direction control. When high, the signal propagates from A to B. When low, the signal propagates from B to A.
ŌĒ	19	A4	Ι	Output enable
GND	10	E1		Ground
V _{CC}	20	A3	_	Power pin

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TEXAS INSTRUMENTS

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7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT	
V_{CC}	Supply voltage range	Supply voltage range				
VI	Input voltage range ⁽²⁾	-0.5	6.5	V		
Vo	Voltage range applied to any output in the high-impedance or	-0.5	6.5	V		
Vo	Voltage range applied to any output in the high or low state ⁽²⁾⁽	(3)	-0.5	V _{CC} + 0.5	V	
I _{IK}	Input clamp current VI	< 0		-50	mA	
I _{OK}	Output clamp current V _O	₀ < 0		-50	mA	
I _O	Continuous output current			±50	mA	
	Continuous current through V_{CC} or GND		±100	mA		
T _{stg}	Sto	orage temperature range	-65	150	°C	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the *Recommended Operating Conditions* table.

7.2 ESD Ratings

	PARAMETER	DEFINITION	VALUE	UNIT
	Electrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	2000	
V	(ESD) discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	1000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			T _A =	25°C	–40°C TO	85°C	–40°C TO	LINUT	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
V	Supply voltogo	Operating	1.65	3.6	1.65	3.6	1.65	3.6	V
V _{CC}	Supply voltage	Data retention only	1.5		1.5		1.5		v
		V_{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$		$0.65 \times V_{CC}$		0.65 × V _{CC}		
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V	1.7		1.7		1.7		V
	vonago	V_{CC} = 2.7 V to 3.6 V	2		2		2		
VIL	Low-level input voltage	$V_{\rm CC}$ = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		0.35 × V _{CC}		0.35 × V _{CC}	
		V_{CC} = 2.3 V to 2.7 V		0.7		0.7		0.7	V
		V_{CC} = 2.7 V to 3.6 V		0.8		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	0	5.5	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	0	V _{CC}	V
		V _{CC} = 1.65 V		-4		-4		-4	
	High-level output	$V_{CC} = 2.3 V$		-8		-8		-8	mA
I _{OH}	current	$V_{CC} = 2.7 V$		-12		-12		-12	ША
		$V_{CC} = 3 V$		-24		-24		-24	
		V _{CC} = 1.65 V		4		4		4	
	Low-level output	$V_{CC} = 2.3 V$		8		8		8	mA
I _{OL}	current	$V_{CC} = 2.7 V$		12		12		12	ШA
		$V_{CC} = 3 V$		24		24		24	
Δt/Δv	Input transition rise	or fall rate		10		10		10	ns/V

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

7.4 Thermal Information

					SN74L	/C245A				
	THERMAL METRIC ⁽¹⁾	DB ⁽²⁾	DGV ⁽²⁾	DW ⁽²⁾	GQN or ZQN ⁽²⁾	N ⁽²⁾	NS ⁽²⁾	PW ⁽²⁾	RGY ⁽³⁾	UNI T
					20 F	PINS				
$R_{ extsf{ heta}JA}$	Junction-to-ambient thermal resistance	106.5	124.1	92.9	78	59.2	83.6	108.1	44.0	
R _{θJC(t}	Junction-to-case(top) thermal resistance	68.1	39.5	60.6		44.9	49.4	43.0	53.0	
$R_{\theta J B}$	Junction-to-board thermal resistance	61.7	65.5	60.4		40.1	51.2	59.1	22.1	°C/
ΨJT	Junction-to-top characterization parameter	28.5	2.1	28.2		29.9	21.9	4.7	3.0	W
ψ_{JB}	Junction-to-board characterization parameter	61.2	64.9	60.0		39.9	50.8	58.6	22.2	
R _{θJC(b}	Junction-to-case(bottom) thermal resistance	—	—	—		_	—	_	16.6	

For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953. (1)

(2) (3) The package thermal impedance is calculated in accordance with JESD 51-7.

The package thermal impedance is calculated in accordance with JESD 51-5.

SN74LVC245A

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STRUMENTS

EXAS

7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		V	T _A =	= 25°C		–40°C TO	85°C	–40°C TO 1	25°C	
				V _{cc}	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		I _{OH} = −100 μA		1.65 V to 3.6 V	V _{CC} - 0.2			V _{CC} – 0.2		V _{CC} – 0.2		
		$I_{OH} = -4 \text{ mA}$		1.65 V	1.29			1.2		1.1		
V _{ОН}		I _{OH} = -8 mA		2.3 V	1.9			1.7		1.6		V
		10 m		2.7 V	2.2			2.2		2.1		
		I _{OH} = -12 mA		3 V	2.4			2.4		2.3		
		I _{OH} = -24 mA		3 V	2.3			2.2		2.1		
		I _{OL} = 100 μA		1.65 V to 3.6 V			0.1		0.2		0.2	V
V _{OL}		$I_{OL} = 4 \text{ mA}$		1.65 V			0.24		0.45		0.60	
• OL		I _{OL} = 8 mA		2.3 V			0.3		0.7		0.75	
		I _{OL} = 12 mA	2.7 V			0.4		0.4		0.6		
		I _{OL} = 24 mA	3 V			0.55		0.55		0.75		
I _I	Control inputs	$V_{I} = 0 \text{ to } 5.5 \text{ V}$		3.6 V			±1		±5		±10	μA
I _{off}		$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		0			±1		±10		±20	μA
$I_{OZ}^{(1)}$		$V_0 = 0$ to 5.5 V		3.6 V			±1		±10		±20	μA
		$V_I = V_{CC}$ or GND	1 = 0	3.6 V			1		10		30	
I _{CC}		$3.6 \text{ V} \le \text{V}_{\text{I}} \le 5.5 \text{ V}^{(2)}$	$I_{O} = 0$	3.0 V			1	10		30		μA
ΔI _{CC}		One input at $V_{CC} - 0.6 V$, Other inputs at V_{CC} or GND		2.7 V to 3.6 V			500		500		5000	μA
Ci	Control inputs	$V_{I} = V_{CC}$ or GND		3.3 V		4						pF
C _{io}	A or B ports ⁽³⁾	$V_{I} = V_{CC}$ or GND		3.3 V		5.5						pF

All typical values are at V_{CC} = 3.3 V, T_A = 25 C. (1)

(2) (3) This applies in the disabled state only. For I/O ports, the parameter I_{oz} includes the input leakage current.

7.6 Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	TO	V _{cc}	T _A = 25°C			–40°C 85°	-	–40°C TO 125°C		UNIT	
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX		
			1.8 V ± 0.15 V	1	6	12.2	1	12.7	1	13.7		
	A or B	B or A	2.5 V ± 0.2 V	1	3.9	7.8	1	8.3	1	9.1	~~	
t _{pd}	AUB	BOIA	2.7 V	1	4.2	7.1	1	7.3	1	8.3	ns	
			3.3 V ± 0.3 V	1.5	3.8	6.1	1.5	6.3	1.5	7.3		
		A or B	1.8 V ± 0.15 V	1	7	14.8	1	15.3	1	16.8	16.8 12 11 10	
	OE		2.5 V ± 0.2 V	1	4.5	10	1	10.5	1	12		
t _{en}	0E		2.7 V	1	5.4	9.3	1	9.5	1	11		
			3.3 V ± 0.3 V	1.5	4.4	8.3	1.5	8.5	1.5	10		
			1.8 V ± 0.15 V	1	7.8	16.5	1	17	1	18		
4	OE	A	2.5 V ± 0.2 V	1	4	9	1	9.5	1	10.5		
t _{dis}	UE	A or B	2.7 V	1	4.4	8.3	1	8.5	1	9.5	ns	
			3.3 V ± 0.3 V	1.7	4.1	7.3	1.7	7.5	1.7	8.5		
t _{sk(o)}			3.3 V ± 0.3 V					1		1.5	ns	

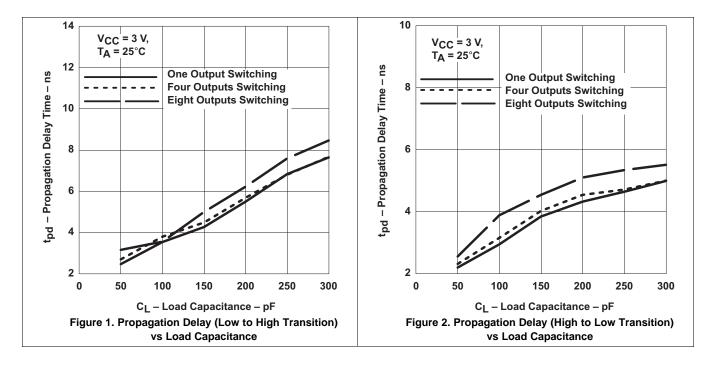
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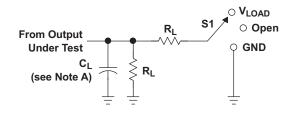
7.7 Operating Characteristics

$T_{A} = 25$	5°C					
	PARAMETER	TEST CONDITIONS	v_{cc}	ТҮР	UNIT	
			1.8 V	42		
		Outputs enabled		2.5 V	43	
<u> </u>	Dower dissinction conscitance per transceiver		f 10 MU-	3.3 V	45	~ -
C _{pd}	Power dissipation capacitance per transceiver		f = 10 MHz	1.8 V	1	pF
		Outputs disabled		2.5 V	1	
				3.3 V	2	

7.8 Typical Characteristics



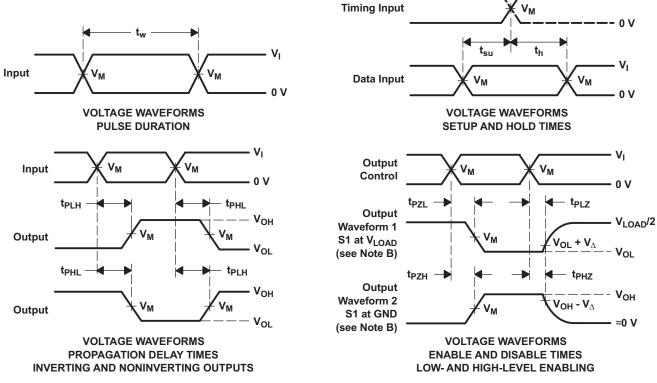
8 Parameter Measurement Information



LOAD CIRCUIT

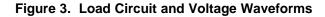
TEST	S1
t _{PLH} /t _{PHL} t _{PLZ} /t _{PZL}	Open V _{LOAD}
t _{PHZ} /t _{PZH}	GND

	INPUTS		N		•	-	N	
V _{cc}	VI	t _r /t _f	V _M	V _{LOAD}	CL	RL	V_{Δ}	
1.8 V ± 0.15 V	V _{cc}	≤2 ns	V _{CC} /2	$2 \times V_{CC}$	30 pF	1 k Ω	0.15 V	
2.5 V ± 0.2 V	V _{CC}	≤2 ns	V _{CC} /2	2 × V _{CC}	30 pF	500 Ω	0.15 V	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V	
3.3 V ± 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V	



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR≤ 10 MHz, Z_O = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{od} .
- H. All parameters and waveforms are not applicable to all devices.



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9 Detailed Description

9.1 Overview

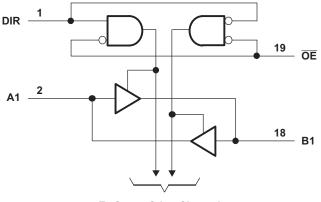
This octal bus transceiver is designed for 1.65-V to 3.6-V V_{CC} operation.

The SN74LVC245A device is designed for asynchronous communication between data buses. This device transmits data from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable (OE) input can be used to disable the device so the buses effectively are isolated.

To ensure the high-impedance state during power up or power down, $\overline{\text{OE}}$ should be tied to V_{CC} through a pull-up resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver. Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

9.2 Functional Block Diagram



To Seven Other Channels

Pin numbers shown are for the DB, DGV, DW, N, NS, PW, and RGY packages.

9.3 Feature Description

- Allows down voltage translation
 - 5 V to 3.3 V
 - 5 V or 3.3 V to 1.8 V
- Inputs accept voltage levels up to 5.5 V

9.4 Device Functional Modes

 Table 1. Function Table

INPU	JTS	OPERATION				
OE	DIR	OPERATION				
L	L	B data to A bus				
L	Н	A data to B bus				
Н	Х	Isolation				



10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

SN74LVC245A is a high drive CMOS device that can be used for a multitude of bus interface type applications where output drive or PCB trace length is a concern. The inputs can accept voltages to 5.5 V at any valid V_{CC} making it ideal for down translation.

10.2 Typical Application

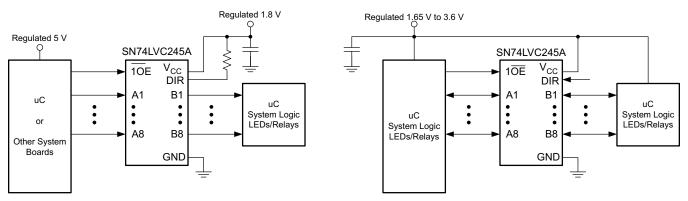


Figure 4. Typical Application Schematic

10.2.1 Design Requirements

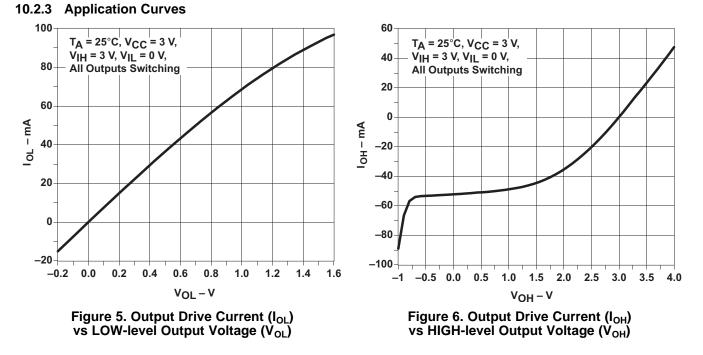
This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions should be considered to prevent ringing.

10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
 - For rise time and fall time specifications, see ($\Delta t/\Delta V$) in the *Recommended Operating Conditions* table.
 - For specified high and low levels, see (V_{IH} and V_{IL}) in the *Recommended Operating Conditions* table.
 - Inputs are overvoltage tolerant allowing them to go as high as (V₁ max) in the *Recommended Operating Conditions* table at any valid V_{CC}.
- 2. Recommend Output Conditions
 - Load currents should not exceed (I_O max) per output and should not exceed (Continuous current through V_{CC} or GND) total current for the part. These limits are located in the *Absolute Maximum Ratings* table.
 - Outputs should not be pulled above V_{CC} .



Typical Application (continued)



11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1 μ F capacitor is recommended. If there are multiple V_{CC} terminals then 0.01 μ F or 0.022 μ F capacitors are recommended for each power terminal. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. Multiple bypass capacitors may be paralleled to reject different frequencies of noise. The bypass capacitor should be installed as close to the power terminal as possible for the best results.

12 Layout

12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 7 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} , whichever makes more sense or is more convenient.

12.2 Layout Example



Figure 7. Layout Diagram

13 Device and Documentation Support

13.1 Trademarks

All trademarks are the property of their respective owners.

13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LVC245ADBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245ADBRE4	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245ADBRG4	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245ADGVR	ACTIVE	TVSOP	DGV	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245ADW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC245A	Samples
SN74LVC245ADWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC245A	Samples
SN74LVC245ADWRG4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC245A	Samples
SN74LVC245AN	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74LVC245AN	Samples
SN74LVC245ANE4	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74LVC245AN	Samples
SN74LVC245ANSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC245A	Samples
SN74LVC245APW	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWE4	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWG4	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWRE4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWRG3	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245APWT	ACTIVE	TSSOP	PW	20	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC245A	Samples
SN74LVC245ARGYR	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LC245A	Samples

⁽¹⁾ The marketing status values are defined as follows:



27-Feb-2021

ACTIVE: Product device recommended for new designs. LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption. **Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74LVC245A :

Enhanced Product: SN74LVC245A-EP

NOTE: Qualified Version Definitions:

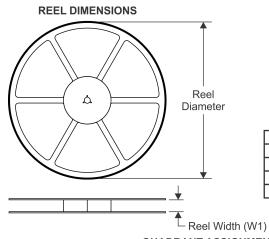
• Enhanced Product - Supports Defense, Aerospace and Medical Applications

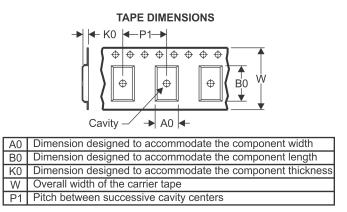
PACKAGE MATERIALS INFORMATION

Texas Instruments

www.ti.com

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

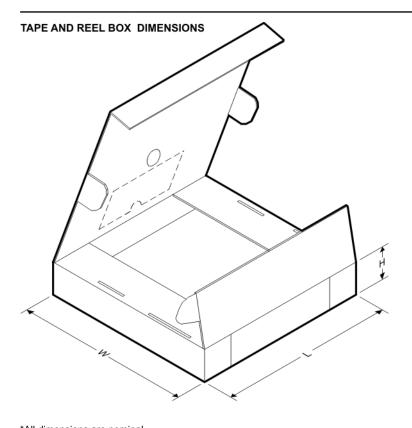


*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC245ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LVC245ADGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC245ADWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74LVC245ANSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LVC245APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC245APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LVC245APWRG3	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC245APWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LVC245APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC245ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1



PACKAGE MATERIALS INFORMATION

21-Feb-2022



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC245ADBR	SSOP	DB	20	2000	853.0	449.0	35.0
SN74LVC245ADGVR	TVSOP	DGV	20	2000	853.0	449.0	35.0
SN74LVC245ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LVC245ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LVC245APWR	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LVC245APWR	TSSOP	PW	20	2000	853.0	449.0	35.0
SN74LVC245APWRG3	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LVC245APWRG4	TSSOP	PW	20	2000	853.0	449.0	35.0
SN74LVC245APWT	TSSOP	PW	20	250	853.0	449.0	35.0
SN74LVC245ARGYR	VQFN	RGY	20	3000	853.0	449.0	35.0



21-Feb-2022

TUBE



*All	dimensions	are	nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN74LVC245ADW	DW	SOIC	20	25	507	12.83	5080	6.6
SN74LVC245AN	N	PDIP	20	20	506	13.97	11230	4.32
SN74LVC245ANE4	N	PDIP	20	20	506	13.97	11230	4.32
SN74LVC245APW	PW	TSSOP	20	70	530	10.2	3600	3.5
SN74LVC245APWE4	PW	TSSOP	20	70	530	10.2	3600	3.5
SN74LVC245APWG4	PW	TSSOP	20	70	530	10.2	3600	3.5

DB0020A



PACKAGE OUTLINE

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



DB0020A

EXAMPLE BOARD LAYOUT

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DB0020A

EXAMPLE STENCIL DESIGN

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUAD FGLATPACK - NO LEAD

3.5 x 4.5, 0.5 mm pitch

RGY 20

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





4225264/A

RGY0020A



PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



RGY0020A

EXAMPLE BOARD LAYOUT

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



RGY0020A

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



PW0020A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0020A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0020A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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